

**Notice of References Cited**

Application/Control No.

10/021,567

Applicant(s)/Patent Under  
Reexamination  
FUJIWARA, HIDEMICHI

Examiner

Chau N Nguyen

Art Unit

2831

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,239,373 /	05-2001	Sato et al.	174/75C
	B	US-4,729,939 /	03-1988	Nishikawa et al.	420/543
	C	US-5,514,837 /	05-1996	Kenny et al.	174/110FC
	D	US-4,408,089 /	10-1983	Nixon, Charles E.	174/106R
	E	US-5,532,910 /	07-1996	Suzuki et al.	174/52.4
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	2001-226754 /	08-2001	Japan		
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.